

**Notice of References Cited**

Application/Control No.

10/056,295

Applicant(s)/Patent Under  
Reexamination  
SCHRECK ET AL.

Examiner

William J. Klimowicz

Art Unit

2627

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,961,123	10-1990	Williams et al.	360/131
*	B	US-5,626,941	05-1997	Ouano, Augustus C.	428/141
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05334666 A	12-1993	Japan	KOMORITANI et al.	
	O	JP 05334667 A	12-1993	Japan	KOMORITANI et al.	
	P	JP 10124843 A	05-1998	Japan	CHIBA, YUKIYA	
	Q	JP 10208297 A	08-1998	Japan	MIZUMA et al.	
	R	JP 10269569 A	10-1998	Japan	SUZUKI, KAZUYA	
	S	JP 2000306236 A	11-2000	Japan	FURUKAWA, AKIO	
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.